



**THE DATASHEET OF
FDS86267P**



MOSFET – P-Channel, Shielded Gate, POWERTRENCH®

-150 V, -2.2 A, 255 mΩ

FDS86267P

General Description

This P-Channel MOSFET is produced using onsemi's advanced POWERTRENCH process that incorporates shielded gate technology. The process has been optimized for the on-state resistance and yet maintain superior switching performance.

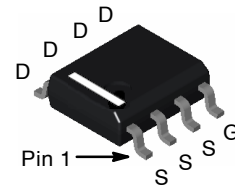
Features

- Shielded Gate MOSFET Technology
- Max $R_{DS(ON)} = 255 \text{ m}\Omega$ @ $V_{GS} = -10 \text{ V}$, $I_D = -2.2 \text{ A}$
- Max $R_{DS(ON)} = 290 \text{ m}\Omega$ @ $V_{GS} = -6 \text{ V}$, $I_D = -2 \text{ A}$
- Very Low $R_{DS(on)}$ Mid Voltage P-channel Silicon Technology Optimised for Low Qg
- This Product is Optimised for Fast Switching Applications as well as Load Switch Applications
- 100% UIL Tested
- This Device is Pb-Free, Halide Free and is RoHS Compliant

Applications

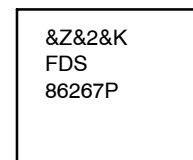
- Active Clamp Switch
- Load Switch

V_{DS}	$R_{DS(on)}$ MAX	I_D MAX
-150 V	255 mΩ @ -10 V	-2.2 A
	290 mΩ @ -6 V	



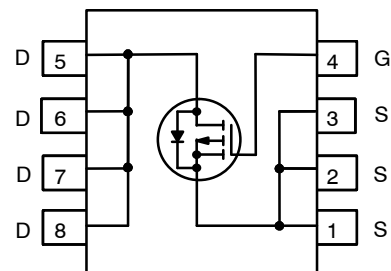
SOIC8
 CASE 751EB

MARKING DIAGRAM



- &Z = Assembly Plant Code
- &2 = 2-Digit Date Code (Year & Week)
- &K = 2-Digit Lot Run Traceability Code
- FDS86267P = Specific Device Code

PIN CONNECTIONS



ORDERING INFORMATION

Device	Package	Shipping†
FDS86267P	SOIC8	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, [BRD8011/D](#).

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ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
V _{DS}	Drain to Source Voltage	-150	V
V _{GS}	Gate to Source Voltage	±25	V
I _D	Drain Current	Continuous (Note 1a)	-2.2
		Pulsed (Note 4)	-34
E _{AS}	Single Pulse Avalanche Energy (Note 3)	54	mJ
P _D	Power Dissipation	T _A = 25°C (Note 1a)	2.5
		T _A = 25°C (Note 1b)	1.0
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
R _{θJA}	Thermal Resistance, Junction to Ambient (Note 1a)	50	°C/W
	Thermal Resistance, Junction to Ambient (Note 1b)	125	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

BV _{DSS}	Drain to Source Breakdown Voltage	I _D = -250 μA, V _{GS} = 0 V	-150	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = -250 μA, Referenced to 25°C	-	-121	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -120 V, V _{GS} = 0 V	-	-	-1	μA
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±25 V, V _{DS} = 0 V	-	-	±100	nA

ON CHARACTERISTICS

V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = -250 μA	-2	-3	-4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = -250 μA, Referenced to 25°C	-	5	-	mV/°C
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = -10 V, I _D = -2.2 A	-	191	255	mΩ
		V _{GS} = -6 V, I _D = -2 A	-	214	290	
		V _{GS} = -10 V, I _D = -2.2 A, T _J = 125°C	-	342	448	
g _{FS}	Forward Transconductance	V _{DS} = -10 V, I _D = -2.2 A	-	6.8	-	S

DYNAMIC CHARACTERISTICS

C _{iss}	Input Capacitance	V _{DS} = -75 V, V _{GS} = 0 V, f = 1 MHz	-	806	1130	pF
C _{oss}	Output Capacitance		-	54	75	pF
C _{rss}	Reverse Transfer Capacitance		-	1.6	2.3	pF
R _g	Gate Resistance		0.1	3	6	Ω

SWITCHING CHARACTERISTICS

t _{d(on)}	Turn-On Delay Time	V _{DD} = -75 V, I _D = -2.2 A, V _{GS} = -10 V, R _{GEN} = 6 Ω	-	9.7	20	ns
t _r	Rise Time		-	2.5	10	ns
t _{d(off)}	Turn-Off Delay Time		-	17	30	ns
t _f	Fall Time		-	5.7	12	ns

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ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted) (continued)

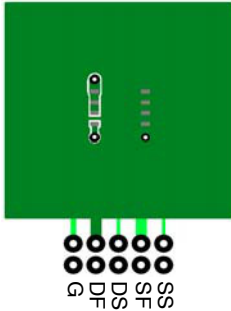
Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
SWITCHING CHARACTERISTICS						
Q_g	Total Gate Charge	$V_{GS} = 0\text{ V to } -10\text{ V}, V_{DD} = -75\text{ V}, I_D = -2.2\text{ A}$	-	11	16	nC
		$V_{GS} = 0\text{ V to } -6\text{ V}, V_{DD} = -75\text{ V}, I_D = -2.2\text{ A}$	-	7	10	nC
Q_{gs}	Gate to Source Charge	$V_{DD} = -75\text{ V}, I_D = -2.2\text{ A}$	-	3.2	-	nC
Q_{gd}	Gate to Drain "Miller" Charge		-	1.9	-	nC

DRAIN-SOURCE DIODE CHARACTERISTICS

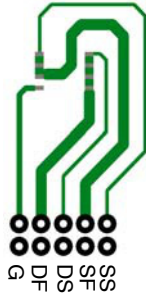
V_{SD}	Source-Drain Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = -2.2\text{ A}$ (Note 2)	-	-0.8	-1.3	V
		$V_{GS} = 0\text{ V}, I_S = -2\text{ A}$ (Note 2)	-	-0.8	-1.2	
t_{rr}	Reverse Recovery Time	$I_F = -2.2\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$	-	65	104	ns
Q_{rr}	Reverse Recovery Charge		-	157	251	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



- 50°C/W when mounted on a 1 in² pad of 2 oz copper.



- 125°C/W when mounted on a minimum pad.

- Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0 %.
- Starting $T_J = 25^\circ\text{C}$, $L = 3\text{ mH}$, $I_{AS} = -6\text{ A}$, $V_{DD} = -150\text{ V}$, $V_{GS} = -10\text{ V}$. 100% tested at $L = 0.3\text{ mH}$, $I_{AS} = -13\text{ A}$.
- Pulsed I_d please refer to Figure 11 SOA graph for more details.

TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

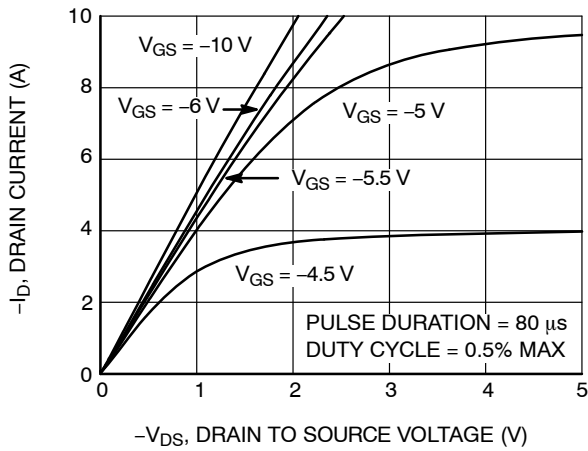


Figure 1. On Region Characteristics

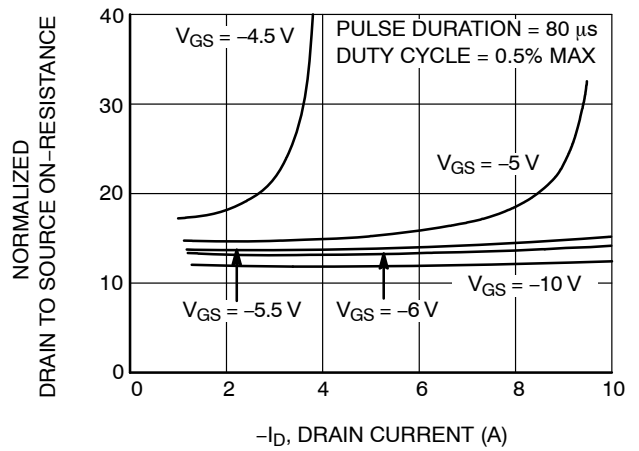


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

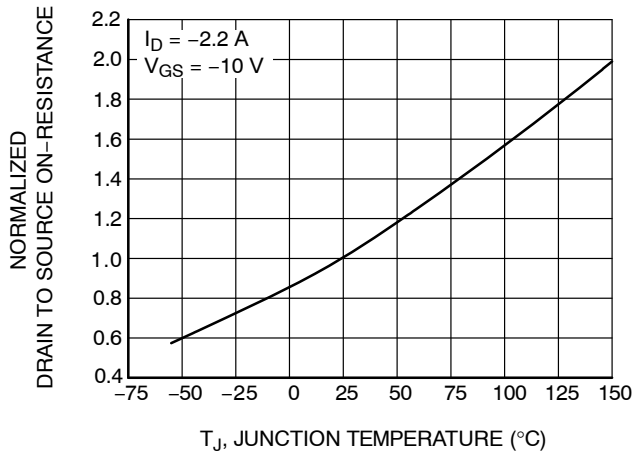


Figure 3. Normalized On Resistance vs. Junction Temperature

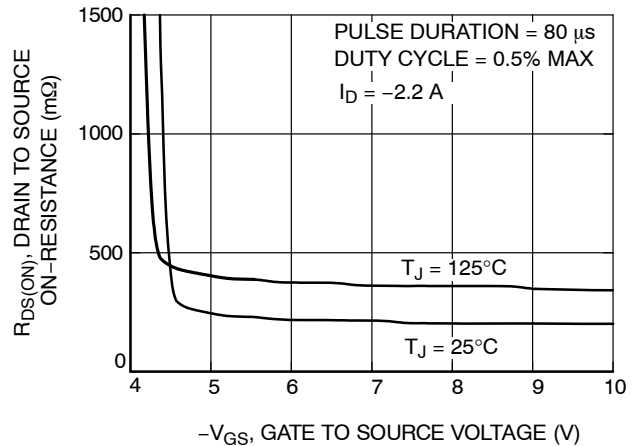


Figure 4. On-Resistance vs. Gate to Source Voltage

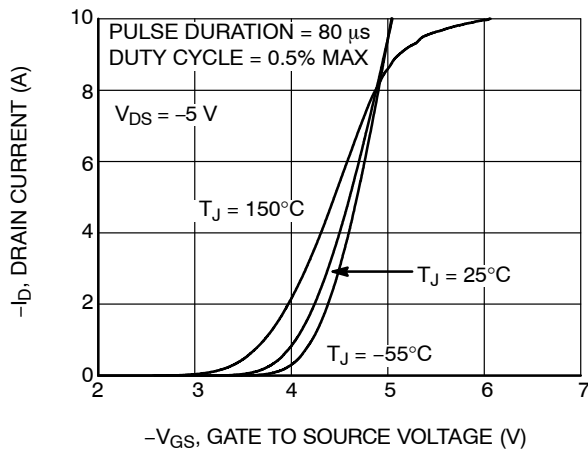


Figure 5. Transfer Characteristics

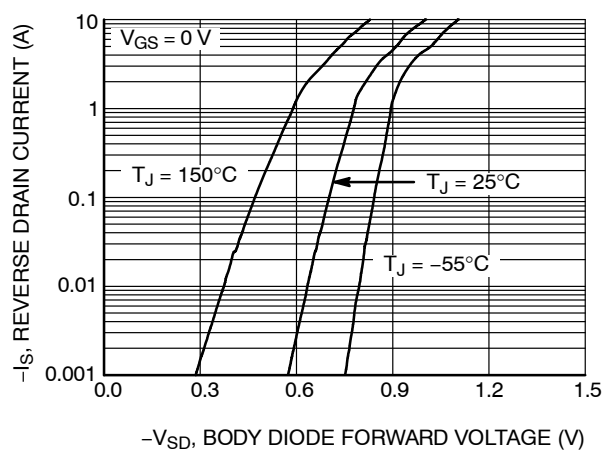


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted) (continued)

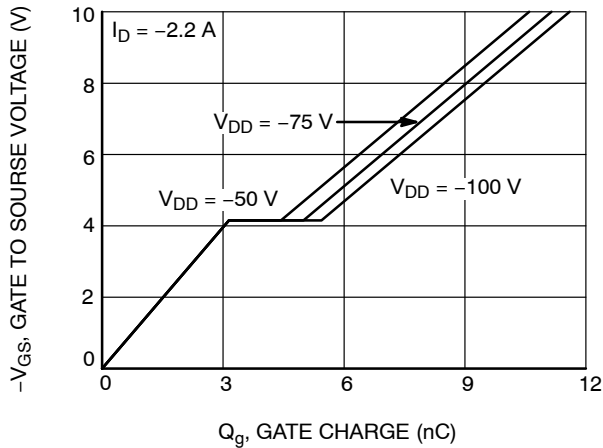


Figure 7. Gate Charge Characteristics

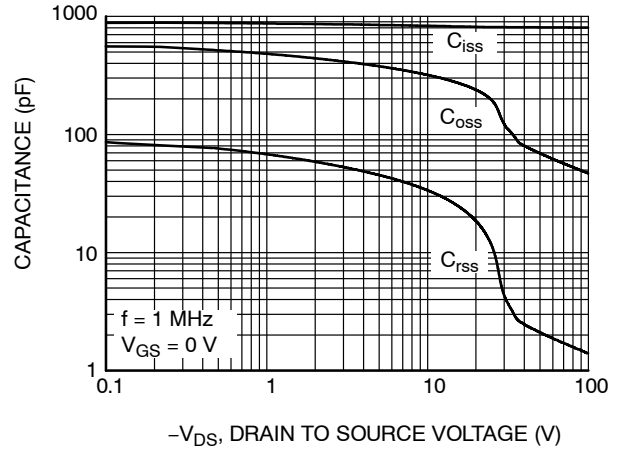


Figure 8. Capacitance vs. Drain to Source Voltage

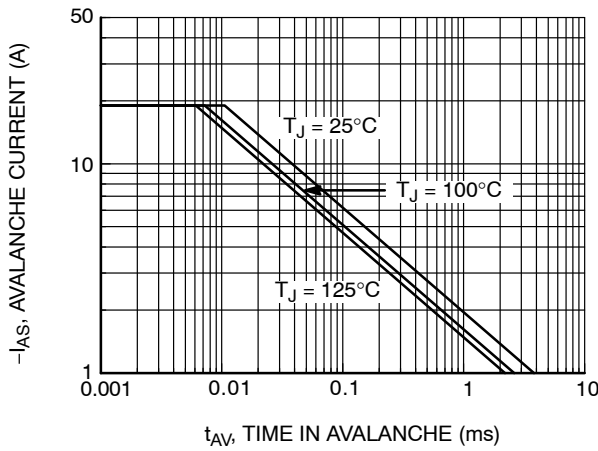


Figure 9. Unclamped Inductive Switching Capability

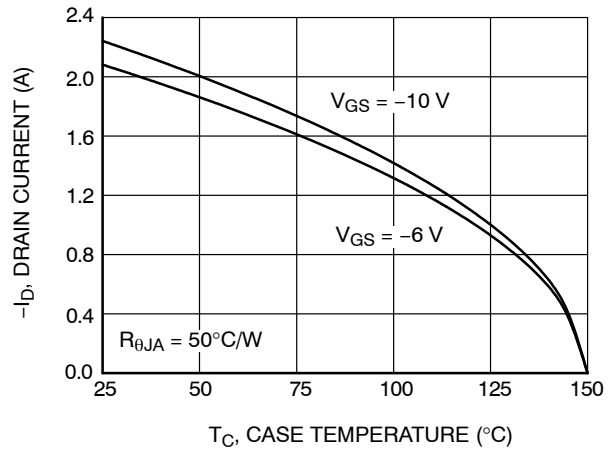


Figure 10. Maximum Continuous Drain Current vs. Ambient Temperature

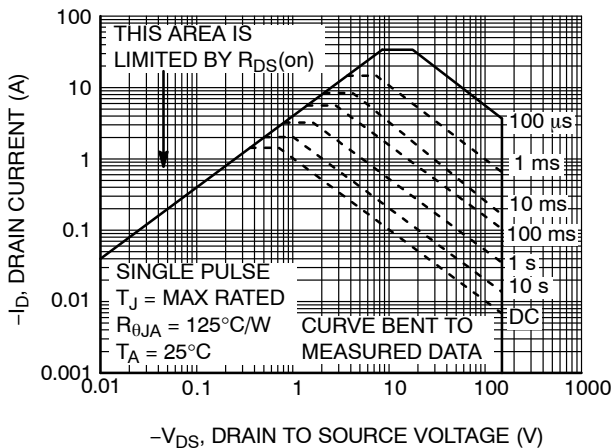


Figure 11. Forward Bias Safe Operating Area

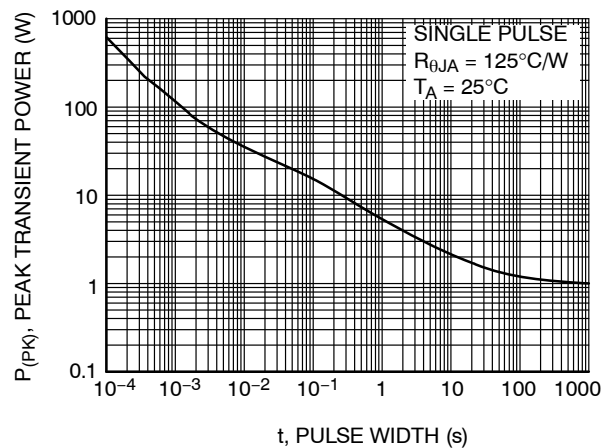


Figure 12. Single Pulse Maximum Power Dissipation

MECHANICAL CASE OUTLINE

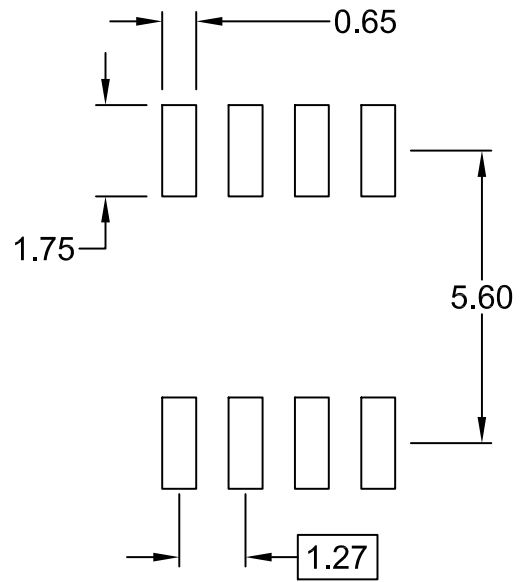
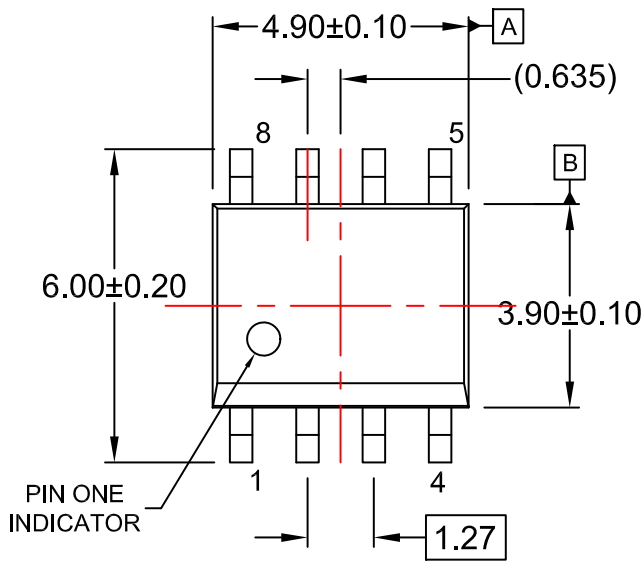
PACKAGE DIMENSIONS

ON Semiconductor®

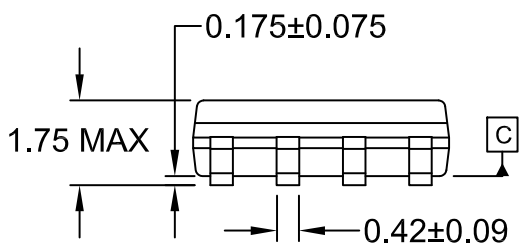


SOIC8
CASE 751EB
ISSUE A

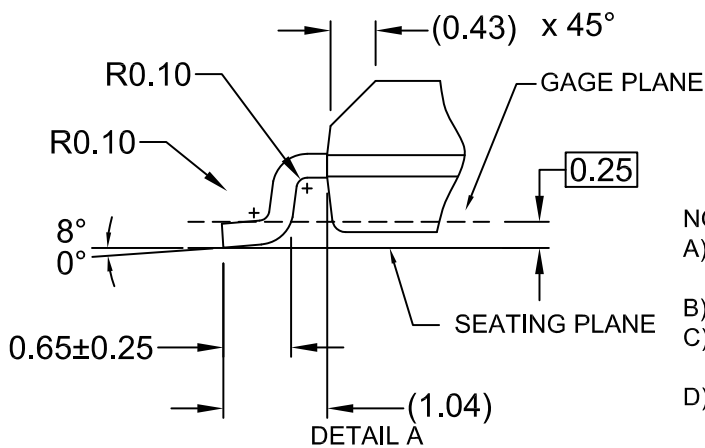
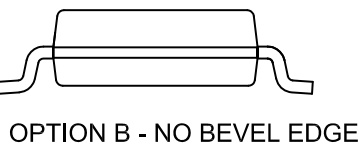
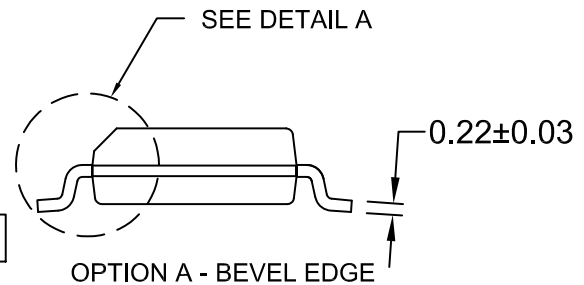
DATE 24 AUG 2017



⊕ 0.25 (M) C B A



⌒ 0.10



DETAIL A
SCALE: 2:1

NOTES:

- A) THIS PACKAGE CONFORMS TO JEDEC MS-012, VARIATION AA.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE MOLD FLASH OR BURRS.
- D) LANDPATTERN STANDARD: SOIC127P600X175-8M

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